

Application/Control No.	Applicant(s)/Patent under Reexamination
09/843,036	TRAPANI ET AL.
Examiner	Art Unit
Quoc A. Tran	2176

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Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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ACM Databaseee Search History Printout	9 /4/2006	Ø
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